



Fig.1 : (a) Structure of a nitride light emitting diode measured by atomic probe tomography (APT). Each point is an atom. The purple layers are 3 nm-thick InGaN quantum wells (QWs). (b) Indium concentration map measured by APT on the middle plane of a QW showing the intrinsic compositional disorder of the InGaN ternary alloy due to the random placement of the atoms on the crystal lattice during growth. (c) Local light emission spectra recorded by scanning tunneling electroluminescence microscopy on an InGaN QW showing photon emission from single localized states induced by the intrinsic compositional disorder of the InGaN ternary alloy.

## **References** :

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